9. ☐ Other .

REASONS FOR ALLOWANCE

The following is an examiner's statement of reasons for allowance:

In regard to claims 1, 8, 18, and 23, the prior art does not disclose or render obvious where a first width is wider than a second width, wherein the first width of the signal trace is located in a signal trace anti-pad region and wherein an impedance discontinuity between the at least one signal trace and a component electrically connected to the at least one via is lowered from above about 5 ohms to less than about 1 ohm in the combination as claimed (also see remarks pgs 7 and 8).

Claims 2, 4-6, 9-13, 15-17, 19-21, and 24 are allowable because they depend from an allowable base claim.

Any comments considered necessary by applicant must be submitted no later than the payment of the issue fee and, to avoid processing delays, should preferably accompany the issue fee. Such submissions should be clearly labeled "Comments on Statement of Reasons for Allowance."

Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jeff Natalini whose telephone number is 571-272-2266. The examiner can normally be reached on M-F 8-5.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Diane Lee can be reached on 571-272-2399. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Application/Control Number: 10/611,791

Art Unit: 2858

Page 3

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jeff Natalini

ANJAN DEB
PRIMARY EXAMINER

frjonh De